SUP/SUB60N06-18

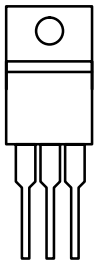
N-Channel Enhancement-Mode Transistors

Product Summary

$V_{(BR)DSS}$ (V)	$r_{DS(on)}$ (Ω)	I_D (A)
60	0.018	60

175°C Rated
Maximum Junction Temperature

TO-220AB



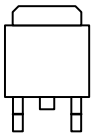
G D S

Top View

SUP60N06-18

DRAIN connected to TAB

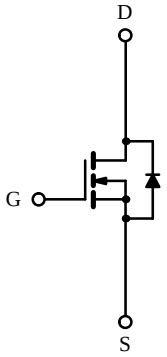
TO-263



G D S

Top View

SUB60N06-18



N-Channel MOSFET

Absolute Maximum Ratings (T_C = 25°C Unless Otherwise Noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current (T_J = 175°C)	T_C = 25°C	I_D	60	A
	T_C = 100°C		39	
Pulsed Drain Current		I_{DM}	120	
Avalanche Current		I_{AR}	60	
Repetitive Avalanche Energy[a]	L = 0.1 mH	E_{AR}	180	mJ
Power Dissipation	T_C = 25°C (TO-220AB and TO-263)	P_D	120[b]	W
	T_A = 25°C (TO-263)[c]		3.7	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	–55 to 175	°C

Thermal Resistance Ratings

Parameter		Symbol	Limit	Unit
Junction-to-Ambient	PCB Mount (TO-263)[c]	R_{thJA}	40	°C/W
	Free Air (TO-220AB)		62.5	
Junction-to-Case		R_{thJC}	1.25	

Notes:
a. Duty cycle ≤ 1%.
b. See SOA curve for voltage derating.
c. When mounted on 1" square PCB (FR-4 material).

Updates to this data sheet may be obtained via facsimile by calling Siliconix FaxBack, 1-408-970-5600. Please request FaxBack document #70290. A SPICE Model data sheet is available for this product (FaxBack document #70540).

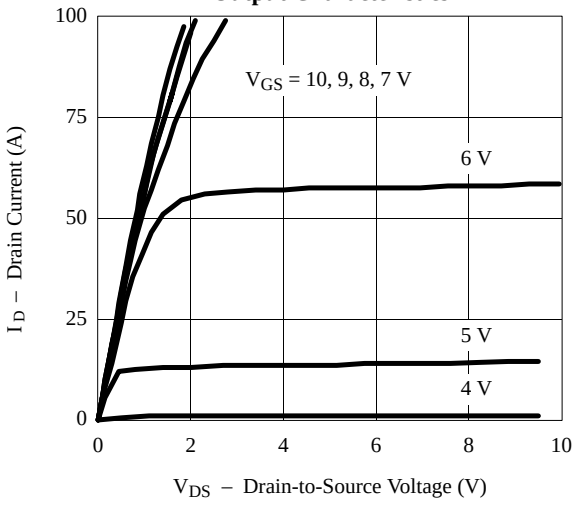
Specifications (T_J = 25°C Unless Otherwise Noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = 250 µA	60			V
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_{DS} = 1 mA	2.0		4.0	
Gate-Body Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ±20 V			±100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 60 V, V_{GS} = 0 V			1	µA
		V_{DS} = 60 V, V_{GS} = 0 V, T_J = 125°C			50	
		V_{DS} = 60 V, V_{GS} = 0 V, T_J = 175°C			150	
On-State Drain Current[b]	$I_{D(on)}$	V_{DS} = 5 V, V_{GS} = 10 V	60			A
Drain-Source On-State Resistance[b]	$r_{DS(on)}$	V_{GS} = 10 V, I_D = 30 A		0.014	0.018	Ω
		V_{GS} = 10 V, I_D = 30 A, T_J = 125°C		0.024	0.030	
		V_{GS} = 10 V, I_D = 30 A, T_J = 175°C		0.031	0.036	
Forward Transconductance[b]	g_{fs}	V_{DS} = 15 V, I_D = 30 A		49		S
Dynamic[a]						
Input Capacitance	C_{iss}	V_{GS} = 0 V, V_{DS} = 25 V, f = 1 MHz		2000		pF
Output Capacitance	C_{oss}			400		
Reversen Transfer Capacitance	C_{rss}			115		
Total Gate Charge[c]	Q_g	V_{DS} = 30 V, V_{GS} = 10 V, I_D = 60 A		39	60	nC
Gate-Source Charge[c]	Q_{gs}			12		
Gate-Drain Charge[c]	Q_{gd}			10		
Turn-On Delay Time[c]	$t_{d(on)}$	V_{DD} = 30 V, R_L = 0.5 Ω I_D ≃ 60 A, V_{GEN} = 10 V, R_G = 2.5 Ω		12	30	ns
Rise Time[c]	t_r			11	30	
Turn-Off Delay Time[c]	$t_{d(off)}$			25	50	
Fall Time[c]	t_f			15	30	
Source-Drain Diode Ratings and Characteristics (T_C = 25°C)[a]						
Continuous Current	I_s				60	A
Pulsed Current	I_{SM}				120	
Forward Voltage[b]	V_{SD}	I_F = 60 A, V_{GS} = 0 V			1.6	V
Reverse Recovery Time	t_{rr}	I_F = 60 A, di/dt = 100 A/µs		60		ns
Peak Reverse Recovery Current	$I_{RM(REC)}$			6.0		A
Reverse Recovery Charge	Q_{rr}			0.4		µC

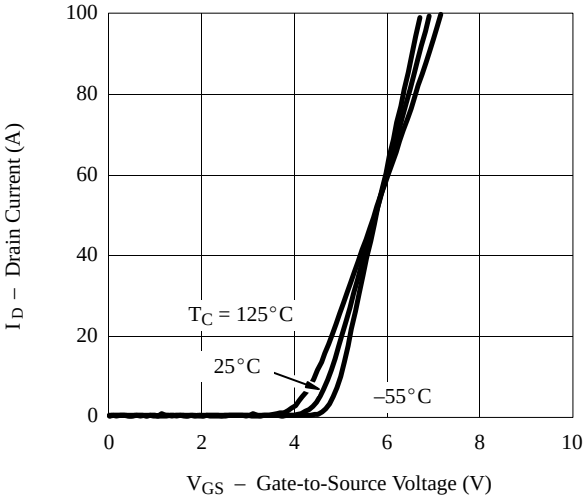
Notes:
a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2%.
c. Independent of operating temperature.

Typical Characteristics (25°C Unless Otherwise Noted)

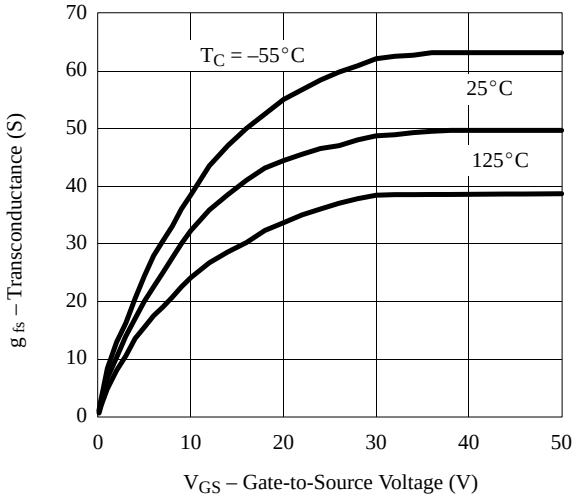
Output Characteristics



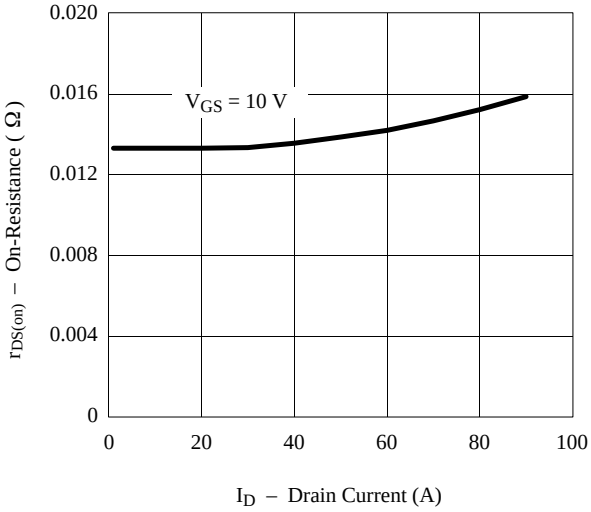
Transfer Characteristics



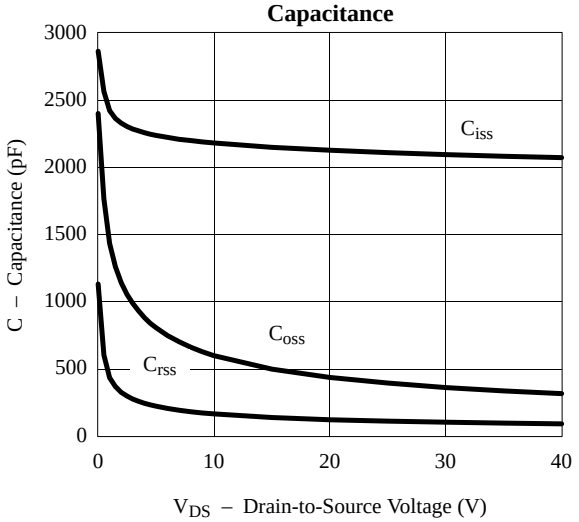
Transconductance



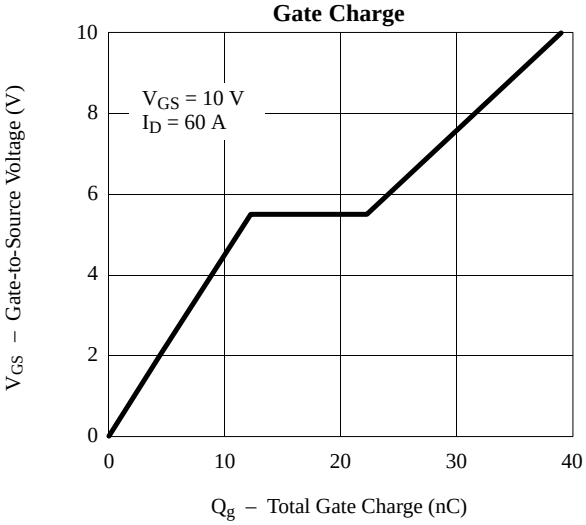
On-Resistance vs. Drain Current



Capacitance

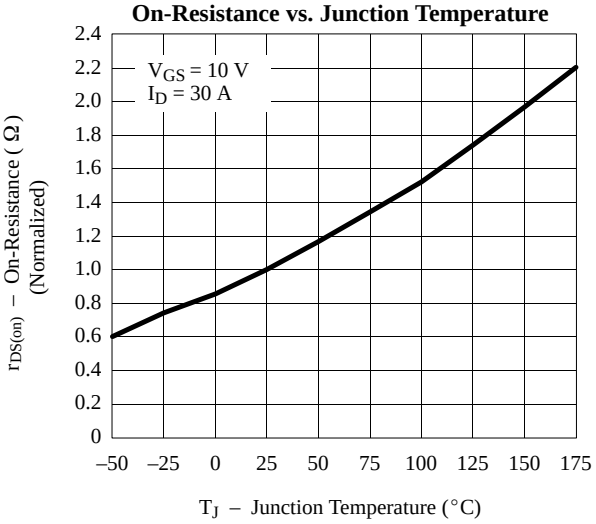


Gate Charge

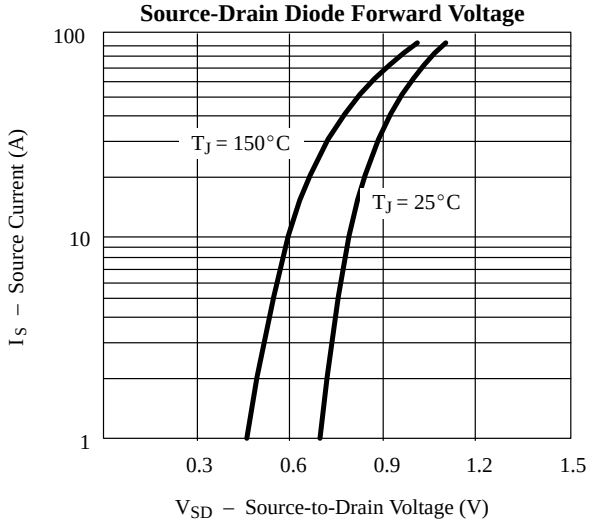


Typical Characteristics (25°C Unless Otherwise Noted)

On-Resistance vs. Junction Temperature

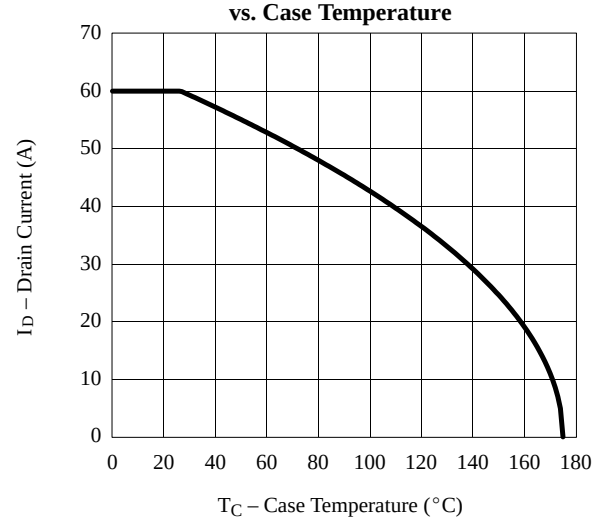


Source-Drain Diode Forward Voltage

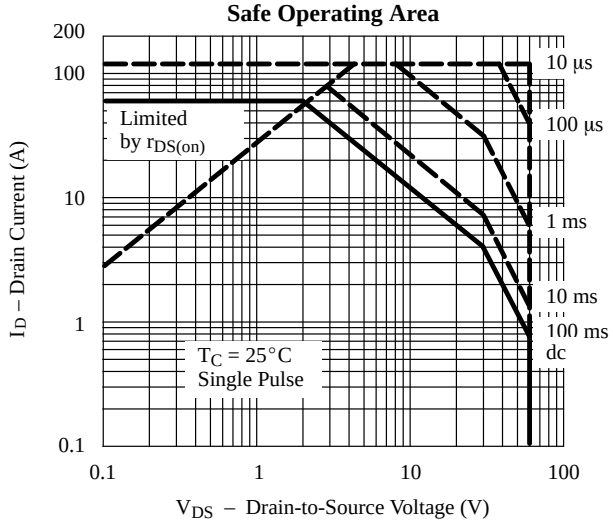
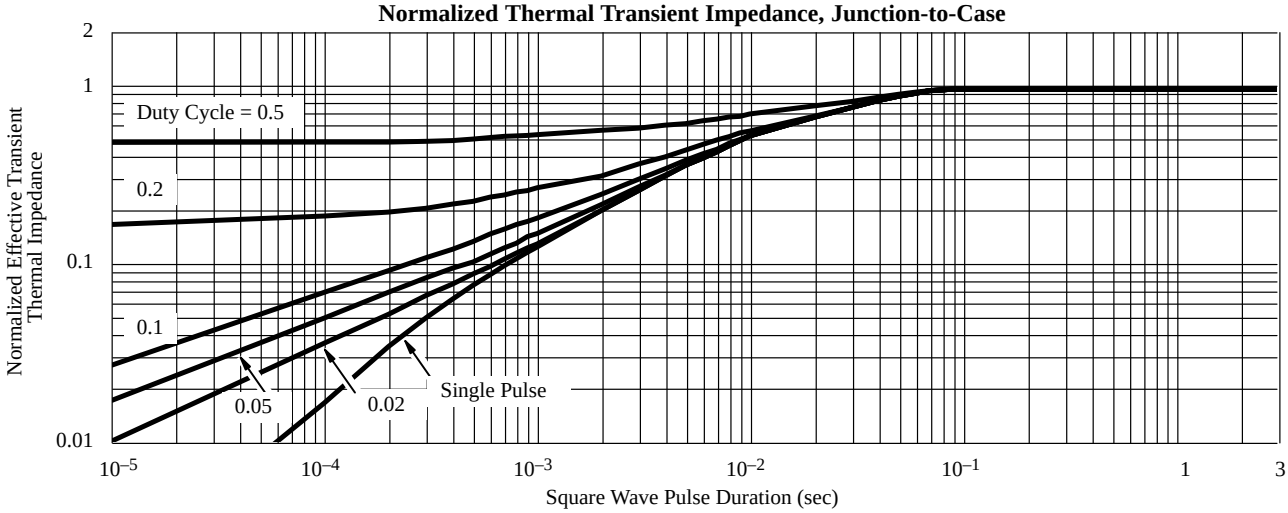


Thermal Ratings

Maximum Avalanche and Drain Current vs. Case Temperature



Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case